

Notice of References Cited	Application/Control No. 10/632,554	Applicant(s)/Patent Under Reexamination TAKANO ET AL.	
	Examiner Shih-wen Hsieh	Art Unit 2861	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,629,787	10-2003	Lee et al.	400/59
	B	US-5,949,447	09-1999	Arai et al.	347/23
	C	US-5,984,470	11-1999	Sakino et al.	347/106
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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